KTC or KTD[†] PACKAGE

(TOP VIEW)

- Low r_{DS(on)} . . . 0.25 Ω Typ
- High Output Voltage . . . 60 V
- Pulsed Current . . . 10 A Per Channel
- Avalanche Energy Capability . . . 105 mJ
- Input Transient Protection . . . 2000 V

description

The TPIC2601 is a monolithic power DMOS array that consists of six electrically isolated N-channel enhancement-mode DMOS transistors configured with a common source and open drains. Each transistor features integrated high-current zener diodes to prevent gate damage in the event that an overstress condition occurs. These zener diodes also provide up to 2000 V of ESD protection when tested using the human-body model.

8 SOURCE/GND
7 GATE3
6 DRAIN3
5 DRAIN3
4 GATE2
3 DRAIN2

2

1

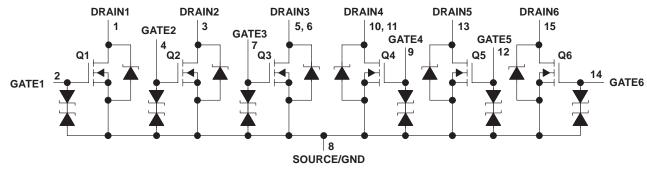
GATE1

DRAIN1

† TI Japan only

The TPIC2601 is offered in a 15-pin PowerFLEX™ (KTC) package and is characterized for operation over the case temperature range of –40°C to 125°C. A 15-pin PowerFLEX™ (KTD) package is also available for TI Japan only.

schematic



NOTE A: For correct operation, no drain terminal may be taken below GND.



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PowerFLEX is a trademark of Texas Intruments Incorporated.



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absolute maximum ratings over operating case temperature range (unless otherwise noted)†

Drain-to-source voltage, V _{DS}	60 V
Gate-to-source voltage, V _{GS}	
Continuous drain current, each output, all outputs on, T _C = 25°C	2 A
Pulsed drain current, each output, I _O max, T _C = 25°C (see Note 1 and Figure 7)	10 A
Continuous gate-to-source zener diode current, T _C = 25°C	±25 mA
Pulsed gate-to-source zener diode current, T _C = 25°C	±250 mA
Single-pulse avalanche energy, E_{AS} , $T_{C} = 25^{\circ}C$ (see Figures 4 and 16)	105 mJ
Continuous total power dissipation at (or below) T _A = 25°C	1.7 W
Power dissipation at (or below) T _C = 75°C, all outputs on	18.75 W
Operating virtual junction temperature range, T _J	40°C to 150°C
Operating case temperature range, T _C	40°C to 125°C
Storage temperature range, T _{stq}	40°C to 125°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: Pulse duration = 10 ms, duty cycle = 2%

electrical characteristics, T_C = 25°C (unless otherwise noted)

	PARAMETER	TEST COND	ITIONS	MIN	TYP	MAX	UNIT
V(BR)DSX	Drain-to-source breakdown voltage	$I_D = 250 \mu\text{A},$	V _{GS} = 0	60			V
V _{GS(th)}	Gate-to-source threshold voltage	I _D = 1 mA,	V _{DS} = V _{GS} ,	1.5	2.05	2.2	V
VGS(th)match	Gate-to-source threshold voltage matching	See Figure 5			5	40	mV
V _(BR) GS	Gate-to-source breakdown voltage	I _{GS} = 250 μA		18			V
V _(BR) SG	Source-to-gate breakdown voltage	I _{SG} = 250 μA		9			V
VDS(on)	Drain-to-source on-state voltage	I _D = 2 A, See Notes 2 and 3	V _{GS} = 10 V,		0.5	0.6	V
VF(SD)	Forward on-state voltage, source-to-drain	Is = 2A, See Notes 2 and 3 ar	VGS = 0, nd Figure 12		0.85	1	V
Inno	Zero-gate-voltage drain current	1 20 - /	T _C = 25°C		0.05	1	
IDSS			T _C = 125°C		0.5	10	μΑ
IGSSF	Forward gate current, drain short circuited to source	V _{GS} = 10 V,	V _{DS} = 0		20	200	nA
IGSSR	Reverse gate current, drain short circuited to source	V _{SG} = 5 V,	V _{DS} = 0		10	100	nA
rpo()	Static drain-to-source on-state resistance	V _{GS} = 10 V, I _D =2 A,	T _C = 25°C		0.25	0.3	Ω
rDS(on)	Static drain-to-source on-state resistance	See Notes 2 and 3 and Figures 6 and 7	T _C = 125°C		0.4	0.5	32
9fs	Forward transconductance	V _{DS} = 15 V, See Notes 2 and 3 and Figure 9	I _D = 1 A	1.3	1.95		S
C _{iss}	Short-circuit input capacitance, common source				180	225	
C _{oss}	Short-circuit output capacitance, common source	$V_{DS} = 25 \text{ V},$ $V_{GS} = 0,$ $f = 1 \text{ MHz}.$ See Figure 9	V _{GS} = 0, See Figure 11		110	138	pF
C _{rss}	Short-circuit reverse transfer capacitance, common source	,	3		80	100	

NOTES: 2. Technique should limit $T_J - T_C$ to 10°C maximum.

^{3.} These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.



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source-to-drain diode characteristics, $T_C = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
trr(SD)	Reverse-recovery time	Is = 1 A, V _{DS} = 48 V,		72		ns
Q _{RR}	Total diode charge	V _{GS} = 0, di/dt = 100 A/μs, See Figures 1 and 14		180		nC

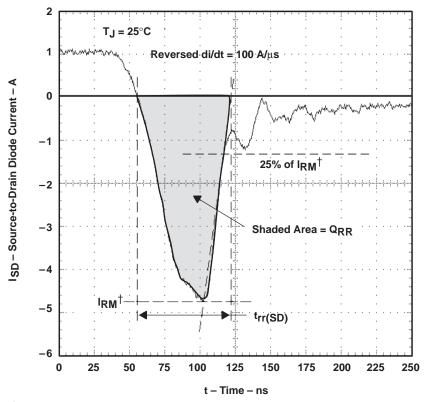
resistive-load switching characteristics, $T_{\hbox{\scriptsize C}}$ = 25 $^{\circ}\hbox{\scriptsize C}$

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
t _d (on)	Delay time, V_{GS}^{\uparrow} to V_{DS}^{\downarrow} turn on		194		
td(off)	Delay time, $V_{GS} \downarrow$ to $V_{DS} \uparrow$ turn off	$V_{DD} = 25 \text{ V}, R_L = 25 \Omega, t_{en} = 10 \text{ ns},$		ns	
t _r	Rise time, V _{DS}	t _{dis} = 10 ns, See Figure 2	90		115
tf	Fall time, V _{DS}		180		
Qg	Total gate charge		5.1	6.4	
Q _{gs(th)}	Threshold gate-to-source charge	$V_{DD} = 48 \text{ V}, I_{D} = 1 \text{ A}, V_{GS} = 10 \text{ V},$ See Figure 3	0.5	0.63	nC
Q _{gd}	Gate-to-drain charge	Goot iguic o	2.75	3.4	
L _D	Internal drain inductance		5		-11
LS	Internal source inductance		5		nH
Rg	Internal gate resistance		500		Ω

thermal resistance

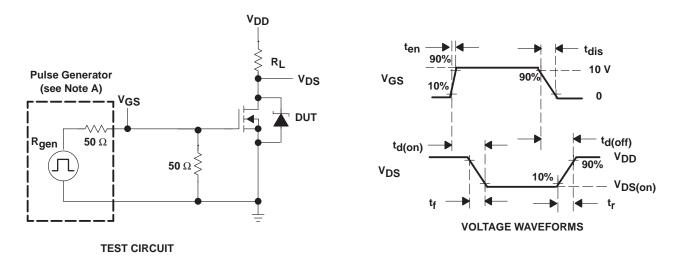
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	All outputs with equal power			72	
$R_{\theta JC}$	Junction-to-case thermal resistance	All outputs with equal power			4	°C/W
	Junction-to-case thermal resistance	One output dissipating power			7	

PARAMETER MEASUREMENT INFORMATION



†I_{RM} = maximum recovery current

Figure 1. Reverse-Recovery Current Waveform of Source-to-Drain Diode



NOTE A: The pulse generator has the following characteristics: $t_{en} \le 10$ ns, $t_{dis} \le 10$ ns, $Z_{O} = 50$ Ω .

Figure 2. Resistive Switching



PARAMETER MEASUREMENT INFORMATION

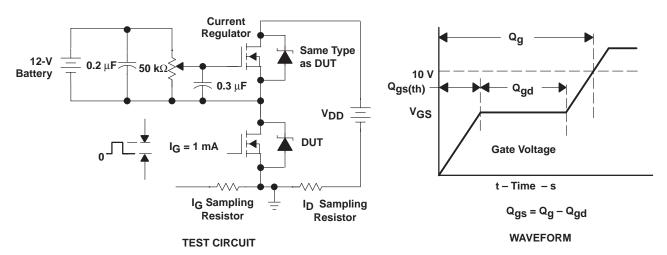
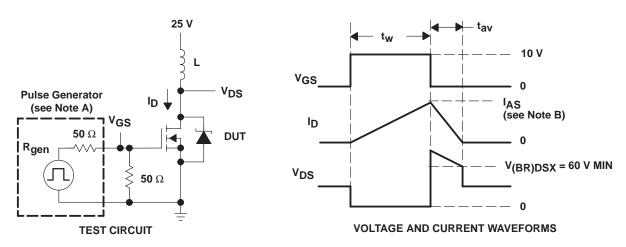


Figure 3. Gate Charge Test Circuit and Waveform



NOTES: A. The pulse generator has the following characteristics: $t_r \le 10$ ns, $t_f \le 10$ ns, $t_O = 50$ Ω .

B. Input pulse duration (t_W) is increased until peak current $I_{AS} = 2 \text{ A}$.

Energy test level is defined as
$$E_{AS} = \frac{I_{AS} \times V_{(BR)DSX} \times t_{av}}{2} = 105 \text{ mJ minimum where } t_{av} = \text{avalanche time.}$$

Figure 4. Single-Pulse Avalanche-Energy Test Circuit and Waveforms

TYPICAL CHARACTERISTICS

GATE-TO-SOURCE THRESHOLD VOLTAGE

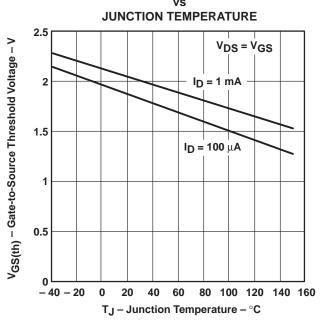


Figure 5

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE

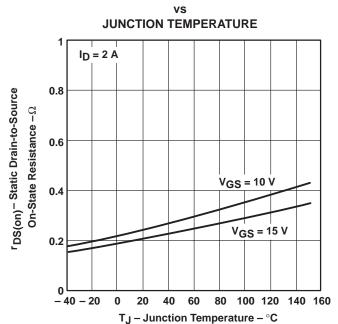


Figure 6

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE

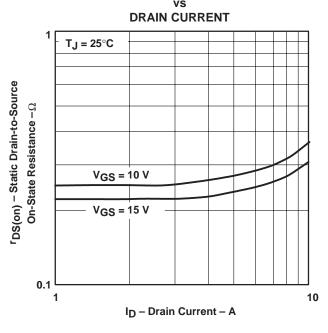


Figure 7

DRAIN CURRENT vs DRAIN-TO-SOURCE VOLTAGE

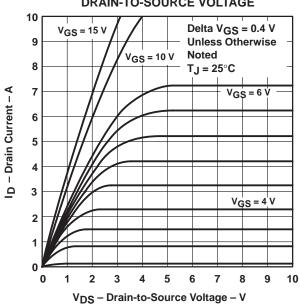


Figure 8



TYPICAL CHARACTERISTICS

DISTRIBUTION OF FORWARD TRANSCONDUCTANCE

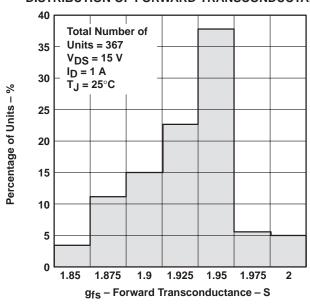
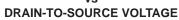


Figure 9

CAPACITANCE



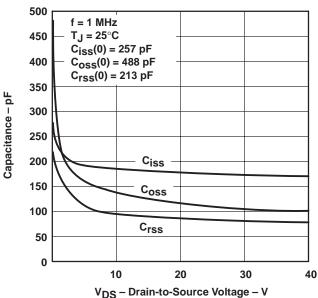


Figure 11

DRAIN CURRENT vs GATE-TO-SOURCE VOLTAGE

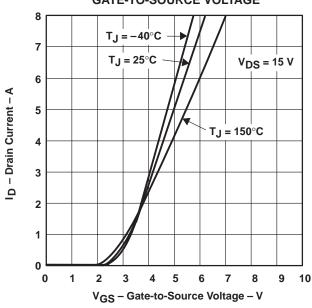


Figure 10

SOURCE-TO-DRAIN DIODE CURRENT vs

vs SOURCE-TO-DRAIN VOLTAGE

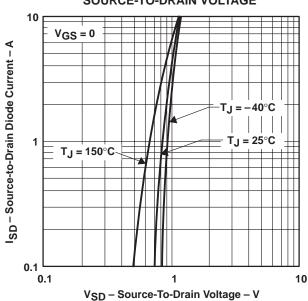


Figure 12

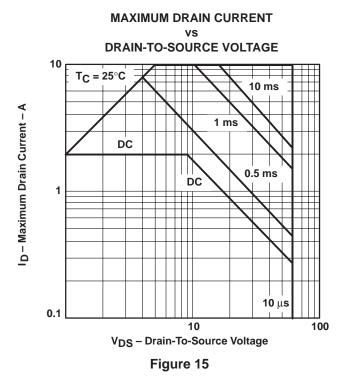
TYPICAL CHARACTERISTICS

DRAIN-TO-SOURCE VOLTAGE AND GATE-TO-SOURCE VOLTAGE vs **GATE CHARGE** 60 12 $T_C = 25^{\circ}C$ See Figure 3 $V_{DD} = 20 V$ 50 V_{DS}- Drain-to-Source Voltage - V V_{GS} - Gate-to-Source Voltage $V_{DD} = 30 V$ 40 8 30 6 20 V_{DD} = 48 V 10 2 $V_{DD} = 20 V$ 0 1 3 5 6 Q_g - Gate Charge - nC

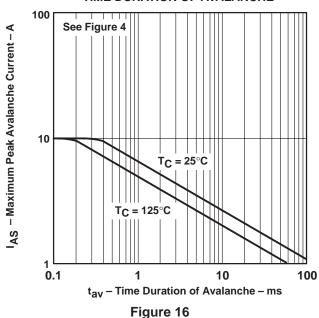


REVERSE-RECOVERY TIME REVERSE di/dt 100 $V_{DS} = 48 V$ 95 $V_{GS} = 0$ Is = 1 A trr - Reverse-Recovery Time - ns 90 T_J = 25°C See Figure 1 85 80 75 70 65 60 55 50 0 50 150 250 300 Reverse di/dt - A/µs

Figure 14



MAXIMUM PEAK AVALANCHE CURRENT vs TIME DURATION OF AVALANCHE

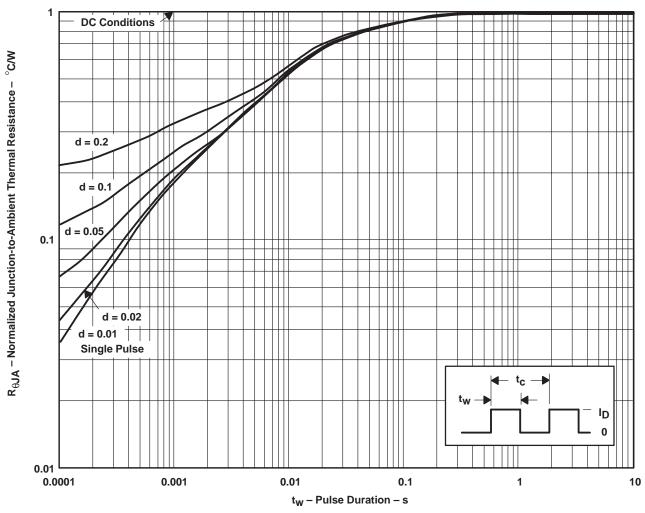


TEXAS INSTRUMENTS

THERMAL INFORMATION

KTC PACKAGE[†] NORMALIZED JUNCTION-TO-AMBIENT THERMAL RESISTANCE





† Device mounted on 24 in², 4-layer FR4 printed-circuit board with no heatsink.

 $\begin{aligned} \text{NOTE A:} \quad Z_{\theta A}(t) &= r(t) \; R_{\theta J A} \\ \quad t_W &= \text{pulse duration} \\ \quad t_C &= \text{cycle time} \\ \quad d &= \text{duty cycle} = t_W/t_C \end{aligned}$

Figure 17





PACKAGE OPTION ADDENDUM

8-Apr-2005

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
TPIC2601KTC	OBSOLETE	PFM	KTC	15	TBD	Call TI	Call TI

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

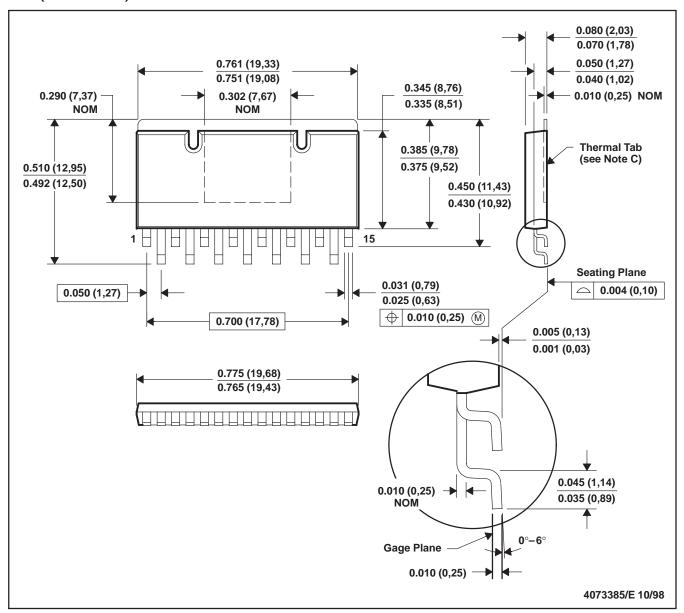
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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KTC (R-PSFM-G15)

PowerFLEX™ PLASTIC FLANGE-MOUNT



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. The heatsink area is approximately 78K sq mils.
- D. Dimensions do not include mold protrusions, not to exceed 0.006 (0,15).

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